

# **HAT2265H**

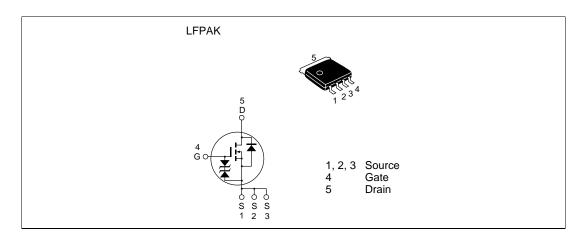
## Silicon N Channel Power MOS FET Power Switching

Rev.0.00 Sept.2004

#### **Features**

- High speed switching
- Capable of 4.5 V gate drive
- Low drive current
- High density mounting
- Low on-resistance  $R_{DS(on)} = 2.5 \ m\Omega \ typ. \ (at \ V_{GS} = 10 \ V)$
- Lead Free

### **Outline**



### HAT2265H

### **Absolute Maximum Ratings**

 $(Ta = 25^{\circ}C)$ 

Item	Symbol	Ratings	Unit
Drain to source voltage	V <sub>DSS</sub>	30	V
Gate to source voltage	V <sub>GSS</sub>	±20	V
Drain current	I <sub>D</sub>	55	A
Drain peak current	I <sub>D(pulse)</sub> Note1	220	A
Body-drain diode reverse drain current	I <sub>DR</sub>	55	A
Avalanche current	I <sub>AP</sub> Note 2	30	A
Avalanche energy	E <sub>AR</sub> Note 2	90	mJ
Channel dissipation	Pch Note3	30	W
Channel to Case Thermal Resistance	θch-C	4.17	°C/W
Channel temperature	Tch	150	°C
Storage temperature	Tstg	-55 to +150	°C

Notes: 1. PW  $\leq$  10  $\mu$ s, duty cycle  $\leq$  1%

<sup>2.</sup> Value at Tch = 25° C, Rg  $\geq$  50  $\Omega$ 

<sup>3.</sup> Tc = 25°C

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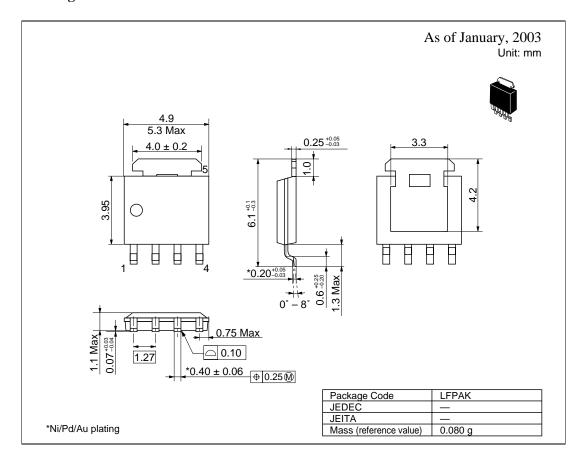
### **Electrical Characteristics**

 $(Ta = 25^{\circ}C)$ 

Item	Symbol	Min	Тур	Max	Unit	Test Conditions
Drain to source breakdown voltage	$V_{(BR)DSS}$	30	_	_	V	$I_D = 10 \text{ mA}, V_{GS} = 0$
Gate to source breakdown voltage	$V_{(BR)GSS}$	± 20	_	_	V	$I_G = \pm 100 \ \mu A, \ V_{DS} = 0$
Gate to source leak current	I <sub>GSS</sub>	_	_	± 10	μΑ	$V_{GS} = \pm 16 \text{ V}, V_{DS} = 0$
Zero gate voltage drain current	I <sub>DSS</sub>	_	_	1	μΑ	$V_{DS} = 30 \text{ V}, V_{GS} = 0$
Gate to source cutoff voltage	$V_{GS(off)}$	1.6	_	2.5	V	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 1 \text{ mA}$
Static drain to source on state	R <sub>DS(on)</sub>	_	2.5	3.3	mΩ	$I_D = 27.5 \text{ A}, V_{GS} = 10 \text{ V}^{\text{Note4}}$
resistance	R <sub>DS(on)</sub>	_	3.4	5.3	mΩ	$I_D = 27.5 \text{ A}, V_{GS} = 4.5 \text{ V}^{\text{Note4}}$
Forward transfer admittance	y <sub>fs</sub>	60	100	_	S	$I_D = 27.5 \text{ A}, V_{DS} = 10 \text{ V}^{\text{Note4}}$
Input capacitance	Ciss	_	5180	_	pF	V <sub>DS</sub> = 10 V
Output capacitance	Coss	_	1200	_	pF	$V_{GS} = 0$
Reverse transfer capacitance	Crss	_	380	_	pF	f = 1 MHz
Gate Resistance	Rg	_	0.5	_	Ω	
Total gate charge	Qg	_	33	_	nc	$V_{DD} = 10 \text{ V}$
Gate to source charge	Qgs	_	15	_	nc	V <sub>GS</sub> = 4.5 V
Gate to drain charge	Qgd	_	7.1	_	nc	I <sub>D</sub> = 55 A
Turn-on delay time	t <sub>d(on)</sub>	_	13	_	ns	$V_{GS} = 10 \text{ V}, I_D = 27.5 \text{ A}$
Rise time	t <sub>r</sub>	_	65	_	ns	
Turn-off delay time	t <sub>d(off)</sub>	_	60	_	ns	$R_L = 0.36 \Omega$
Fall time	t <sub>f</sub>	_	9.5	_	ns	$Rg = 4.7 \Omega$
Body-drain diode forward voltage	$V_{DF}$	_	0.81	1.06	V	$IF = 55 A, V_{GS} = 0^{Note4}$
Body-drain diode reverse recovery time	t <sub>rr</sub>	_	40	_	ns	IF = 55 A, $V_{GS} = 0$ diF/ dt = 100 A/ $\mu$ s

Notes: 4. Pulse test

### **Package Dimensions**



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